

July 2011

FDP075N15A_F102 / FDB075N15A

N-Channel PowerTrench[®] MOSFET 150V, 130A, 7.5m Ω

Features

- $R_{DS(on)} = 6.25 \text{m}\Omega$ (Typ.)@ $V_{GS} = 10 \text{V}$, $I_D = 100 \text{A}$
- · Fast Switching
- · Low Gate Charge
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- · High Power and Current Handling Capability
- RoHS Compliant

Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

- · DC to DC Converters
- Synchronous Rectification for Telecommunication PSU
- · Battery Charger
- · AC motor drives and Uninterruptible Power Supplies
- Off-line UPS



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol		Parameter		FDP075N15A_F102 FDB075N15A	Units
V _{DSS}	Drain to Source Voltage		150	V	
V _{GSS}	Gate to Source Voltage			±20	V
1	Drain Current	-Continuous (T _C = 25°C)		130	
ID	Drain Current	-Continuous (T _C = 100°C)		92	A
I _{DM}	Drain Current	- Pulsed	(Note 1)	522	Α
E _{AS}	Single Pulsed Avalanche En	ergy	(Note 2)	588	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	6.0	V/ns
D	Device Discipation	(T _C = 25°C)		333	W
P_{D}	Power Dissipation	- Derate above 25°C		2.22	W/°C
T _J , T _{STG}	Operating and Storage Tem	perature Range		-55 to +175	οС
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

^{*}Package limitation current is 120A.

Thermal Characteristics

Sy	ymbol	Parameter	FDP075N15A_F102 FDB075N15A	Units
R_{\thetaJC}		Thermal Resistance, Junction to Case	0.45	°C/W
R_{\thetaJA}		Thermal Resistance, Junction to Ambient	62.5	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Description	Quantity
FDP075N15A	FDP075N15A_F102	TO-220	F102: Trimmed Leads	50

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB075N15A	FDB075N15A	D2-PAK	330mm	24mm	800

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	-	-	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.1	-	V/°C
	Zero Gate Voltage Drain Current	V _{DS} = 120V, V _{GS} = 0V	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 120V, T_C = 150^{\circ}C$	-	-	500	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	μА

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10V, I _D = 100A	-	6.25	7.5	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 10V, I _D = 100A (Note 4)	ı	164	İ	S

Dynamic Characteristics

C _{iss}	Input Capacitance	75///	-	5525	7350	pF
Coss	Output Capacitance	$V_{DS} = 75V, V_{GS} = 0V$ f = 1MHz	-	516	685	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1101112	-	21	-	pF
C _{oss(er)}	Energy Related Output Capacitance	$V_{DS} = 75V, V_{GS} = 0V$	-	909	-	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	77	100	nC
Q_{gs}	Gate to Source Gate Charge	\/ - 75 \/ - - 100 \	-	26	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	$V_{DS} = 75V, I_D = 100A$ $V_{GS} = 10V$	-	11	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	.63 .41	-	16	-	nC
ESR	Equivalent Series Resistance(G-S)	Drain Open, f = 1MHz	-	2.29	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		1	28	66	ns
t _r		$V_{DD} = 75V, I_{D} = 100A$	-	37	84	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10V, R_{GEN} = 4.7 Ω	-	62	134	ns
t_f	Turn-Off Fall Time		1	21	52	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current			-	130	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	520	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 100A	-	-	1.25	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, V_{DD} = 75V, I_{SD} = 100A$	-	97	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	264	-	nC

Notes

- ${\bf 1.}\ {\bf Repetitive}\ {\bf Rating:}\ {\bf Pulse}\ {\bf width}\ {\bf limited}\ {\bf by}\ {\bf maximum}\ {\bf junction}\ {\bf temperature}$
- 2. Starting T_J = 25°C, L = 3 mH, I_{AS} = 19.8 A
- 3. I $_{SD} \leq$ 100 A, di/dt \leq 200A/ μ s, V $_{DD} \leq$ BV $_{DSS},$ Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \, \text{Dual Cycle} \leq 2\%$
- ${\bf 5.} \ {\bf Essentially \ Independent \ of \ Operating \ Temperature \ Typical \ Characteristics}$

Typical Performance Characteristics

Figure 1. On-Region Characteristics

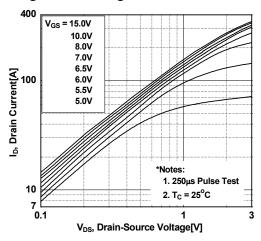


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

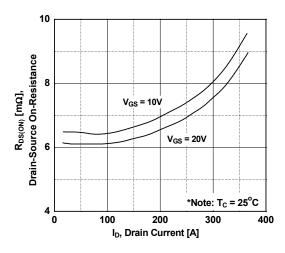


Figure 5. Capacitance Characteristics

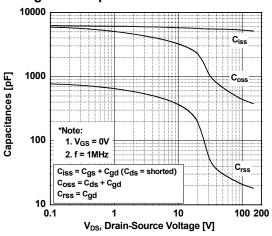


Figure 2. Transfer Characteristics

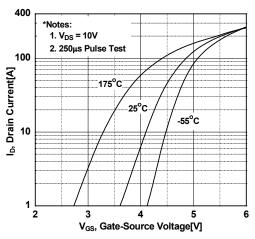


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

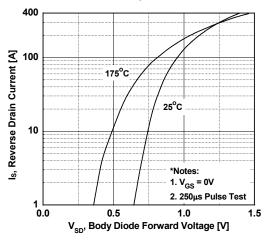
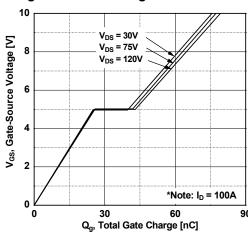


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

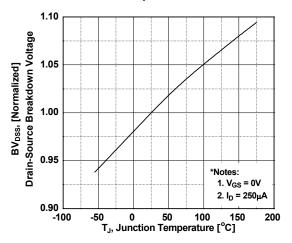


Figure 9. Maximum Safe Operating Area vs. Case Temperature

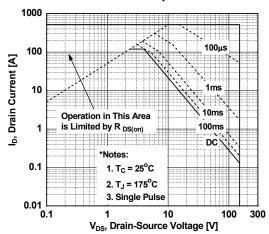


Figure 11. Eoss vs. Drain to Source Voltage

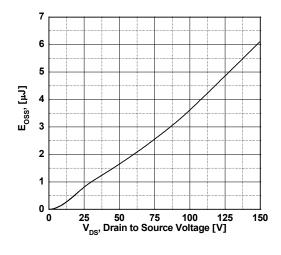


Figure 8. On-Resistance Variation vs. Temperature

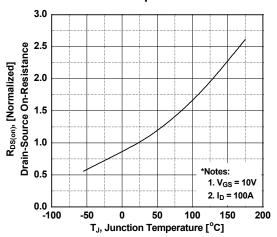


Figure 10. Maximum Drain Current

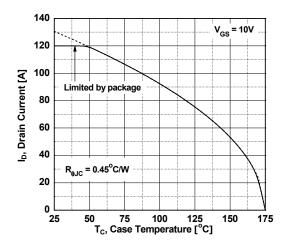
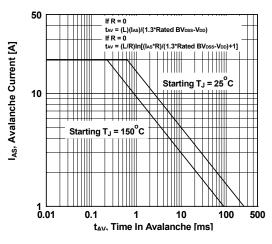
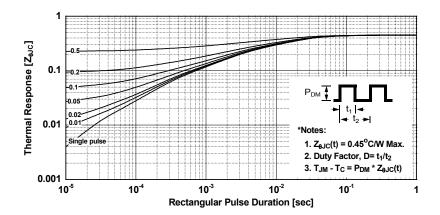


Figure 12. Unclamped Inductive Switching Capability

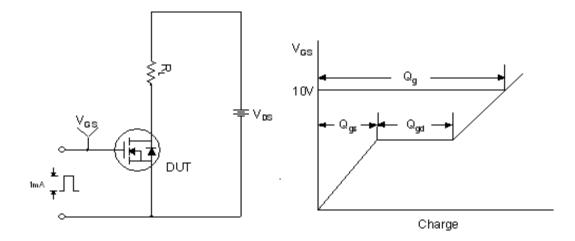


Typical Performance Characteristics (Continued)

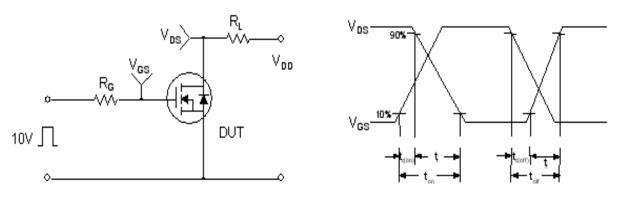
Figure 13. Transient Thermal Response Curve



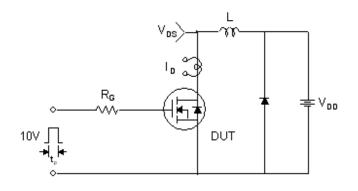
Gate Charge Test Circuit & Waveform

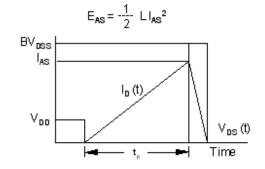


Resistive Switching Test Circuit & Waveforms

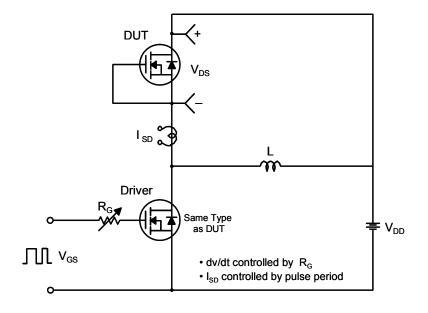


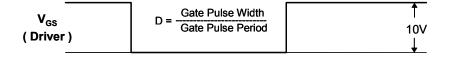
Unclamped Inductive Switching Test Circuit & Waveforms

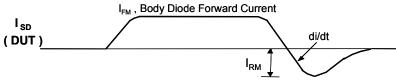




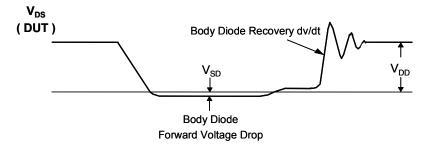
Peak Diode Recovery dv/dt Test Circuit & Waveforms





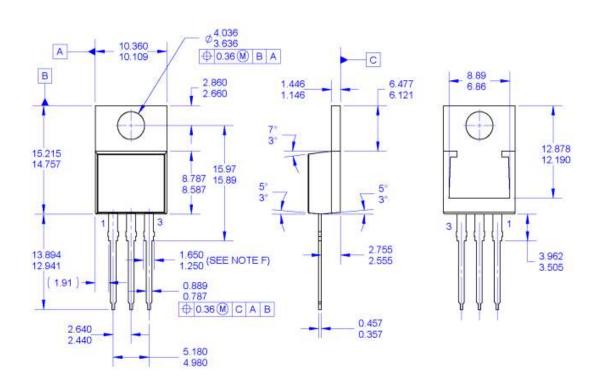


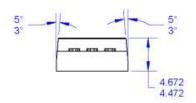
Body Diode Reverse Current



Mechanical Dimensions

TO-220 (F102: Trimmed Leads)





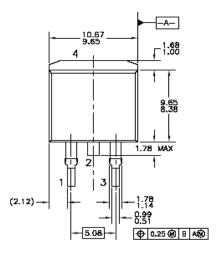
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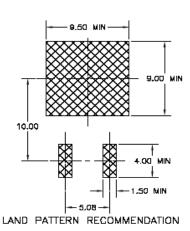
- A. PACKAGE REFERENCE: JEDEC TO220 VARIATION AB
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
 C. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- THIS PACKAGE IS FSZZ INTERNAL PRODUCTION AND INTENDED FOR DELTA CUSTOMER ONLY.
 F. MAX WIDTH FOR F102 DEVICE = 1,35mm.
 G. DRAWING FILE NAME: T0220T03REV2

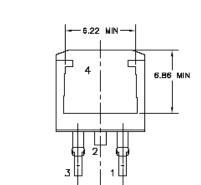
Dimensions in Millimeters

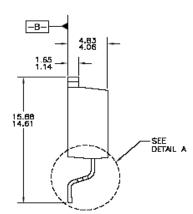
Mechanical Dimensions

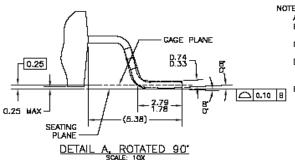
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 D) LOCATION OF THE PIN HOLE MAY VARY
 (LOWER LEFT CORNER, LOWER CENTER
 AND CENTER OF THE PACKAGE).

 B) PRESENCE OF TRIMMED CENTER LEAD
 IS OPTIONAL.

TO283AD2REVD

Dimensions in Millimeters





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